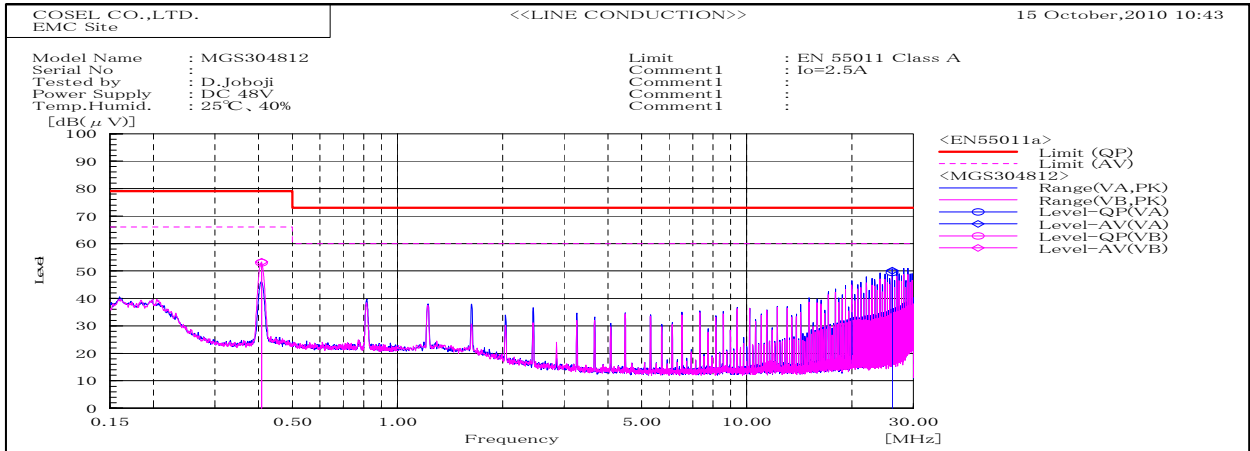
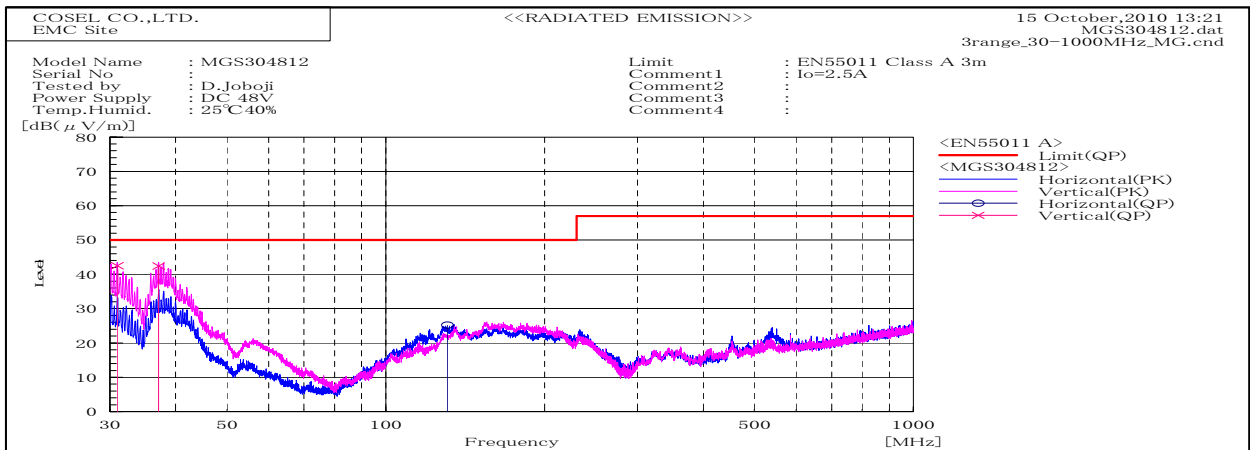


DATA SHEET		Date	19-Oct-10
Model	MGS304812	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	D.Joboji



Frequency MHz	Harm	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.40766		VB	43	43.3	10	53	53.3	79	66	26	12.7	Pass	
26.0907		VA	38.7	39.3	10.8	49.5	50.1	73	60	23.5	9.9	Pass	

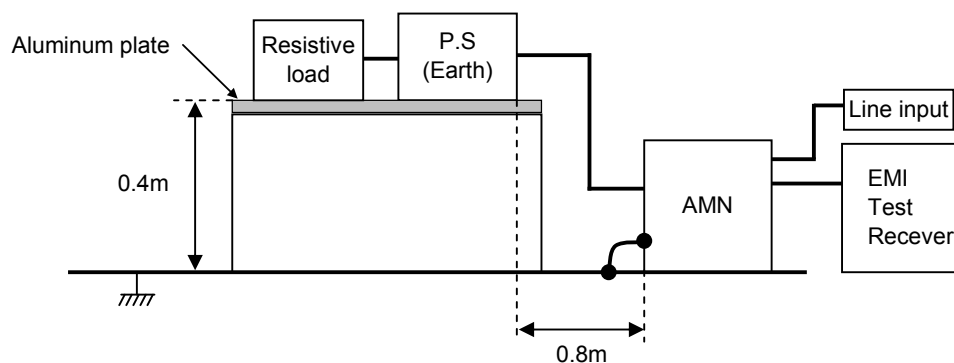


Frequency MHz	Polarization	Stability	Reading dB(μV)		Space Loss dB	Level dB(mW)	Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	QP	QP				
30.992	V	Stable	56.4	-13.9		42.5		50	7.5	Pass	101	306
37.124	V	Stable	59.5	-17.1		42.4		50	7.6	Pass	119	1
130.876	H	Stable	45	-19.8		25.2		50	24.8	Pass	155	297

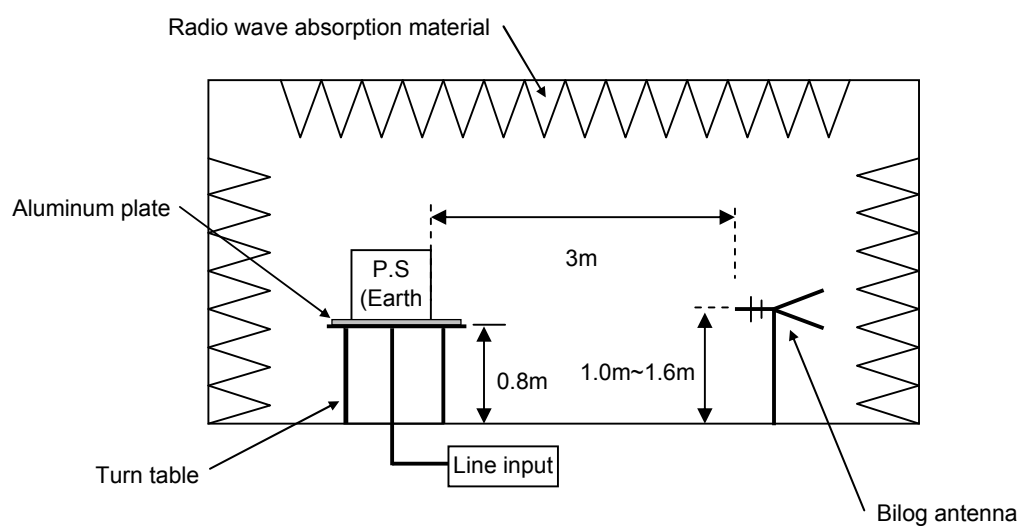
# DATA SHEET

Model	Circuit used for measurement
Test	EMI Line conduction & Radiated emission

## 1. Line conduction



## 2. Radiated emission

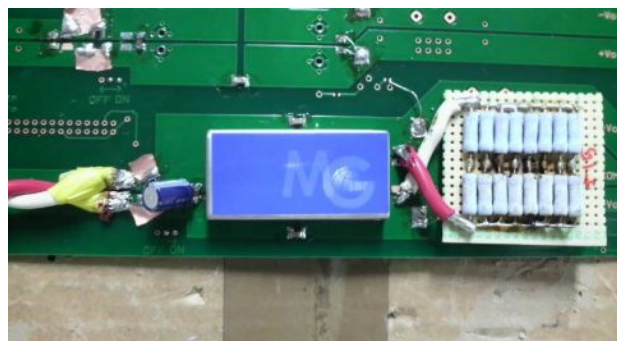


## Conditions

Test : EMI  
 Model Name : MGS3048□□/MGW3048□□

○Photographs of Test Set-Up

### LINE CONDUCTION



### RADIATED EMISSION



○Testing circuitry

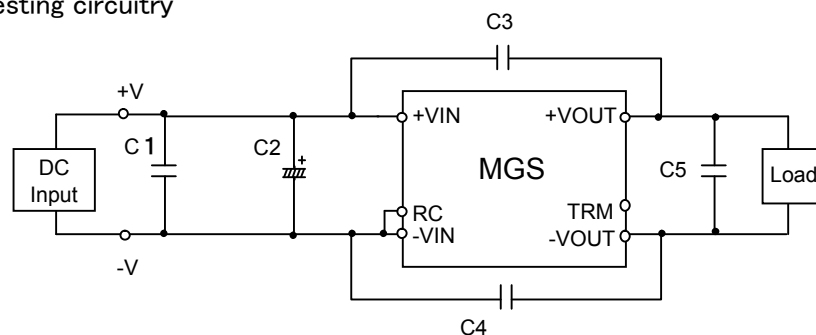


Fig.1 Testing circuitry 1

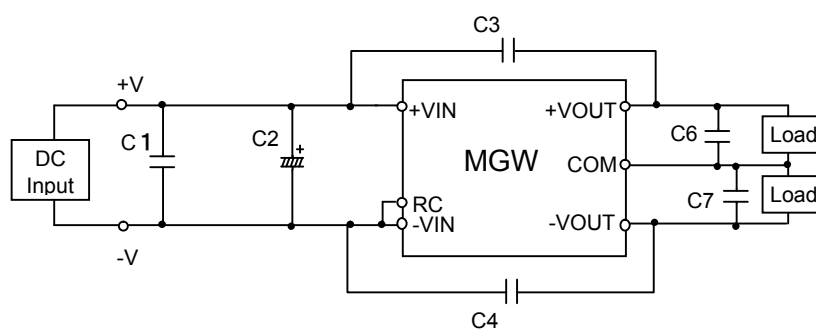


Fig.2 Testing circuitry 2

C1	:	100V	2.2 $\mu$ F	Ceramic Capacitor
C2	:	80V	47 $\mu$ F	Electrolytic Capacitor
C3,C4	:	2kV	1000pF	Ceramic Capacitor
C5,C6,C7	:	25V	22 $\mu$ F	Ceramic Capacitor